

TEST REPORT

No.B23N00001-HAC RF

For

HMD Global Oy

Smartphone

Model Name: TA-1486

With

Hardware Version: V1.00

Software Version: 00WW 1 010 C01

FCC ID: 2AJOTTA-1486

Results Summary: M Category = M3

Issued Date: 2023-03-06

Designation Number: CN1210

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of SAICT.

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REPORT HISTORY

Report Number Revision		Description	Issue Date	
B23N00001-HAC RF	Rev.0	1st edition	2023-03-06	



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1. Summary of Test Report

1.1. Test Items

Description: Smartphone

Model Name: TA-1486

Applicant's Name: HMD Global Oy Manufacturer's Name: HMD Global Oy

1.2. Test Standards

ANSI C63.19-2011

1.3. Test Result

Pass

1.4. Testing Location

Address: Building G, Shenzhen International Innovation Center, No.1006 Shennan Road, Futian District, Shenzhen, Guangdong, P. R. China

1.5. Project Data

Testing Start Date: 2023-01-15 Testing End Date: 2023-01-16

1.6. Signature

Li Yongfu

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(Prepared this test report)

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(Approved this test report)



2. Client Information

2.1. Applicant Information

Company Name:	HMD Global Oy
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City:	Espoo
Country:	Finland
Telephone:	+491735287964

2.2. Manufacturer Information

Company Name:	HMD Global Oy
Address:	Bertel Jungin aukio 9, 02600 Espoo, Finland
City:	Espoo
Country:	Finland
Telephone:	+491735287964



3. Equipment under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description:	Smartphone		
Mode Name:	TA-1486		
Condition of EUT as received:	No obvious damage in appearance		
	GSM 850/1900, WCDMA Band 2/4/5,		
Fraguency Bondo:	LTE Band 2/4/5/7/12/13/17/25/26/38/41/42/43/48/66/71,		
Frequency Bands:	NR n2/n5/n7/n25/n38/n41/n48/n66/n71/n77/n78,		
	Bluetooth, WLAN 2.4GHz, WLAN 5GHz		
Note: The LTE Band 42/43/48 test data is referenced to I22Z62357-SEM10 report.			

3.2. Internal Identification of EUT used during the test

EUT ID*	IMEI	HW Version	SW Version	Receipt Date
UT02aa	352739200025713	V1.00	00WW_1_010_C01	2023-01-04

^{*}EUT ID: is used to identify the test sample in the lab internally.

Note: It is performed to test HAC with the UT02aa.

3.3. Internal Identification of AE used during the test

	AE ID*	ID* Description Model		Manufacturer		
Ī	AE1 Battery LPN388463		LPN388463	Highpower		
Ī	AE2 Headset NLD-EM301K-17SF		NLD-EM301K-17SF	HUIZHOU NEW LEADER INDUSTRY CO., LTD		

 $^{{}^{\}star}\text{AE ID:}$ is used to identify the test sample in the lab internally.

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3.4. Air Interfaces / Bands Indicating Operating Modes

Air-interface	Band(MHz)	Туре	C63.19 / tested	Simultaneous Transmissions	Name of Voice Service	Power Reduction	
GSM	850/1900	VO	Yes	BT,WLAN	CMRS Voice	No	
EDGE	850/1900	DT	No	BT,WLAN	Google Duo	No	
WCDMA	B2/B4/B5	VO	No	BT,WLAN	CMRS Voice	No	
WCDIVIA	HSPA	VD	No	BT,WLAN	Google Duo	No	
LTE (EDD)	2/4/5/7/12/13/	VD	Na	ND DTW// AN	VoLTE,	No	
LTE (FDD)	17/25/26/66/71	VD	No NR,BT	NR,BT,WLAN	Google Duo		
LTE (TDD)	38/41/42/43/48	VD	Yes	ND DTW/LAN	VoLTE,	No	
LTE (TDD)	30/41/42/43/40	VD	res	NR,BT,WLAN	Google Duo	No	
NR (FDD)	n2/n5/n7/n25/n66/n71	VD	No	LTE,BT,WLAN	Google Duo	No	
NR (TDD)	n38/n41/n48/n77/n78	VD	No	LTE,BT,WLAN	Google Duo	No	
WLAN	2.4GHz	VD	No	WWAN	VoWIFI	No	
VVLAIN	2.46 M2	VD	No	VVVVAN	Google Duo	No	
WLAN	5GHz	VD	No	WWAN	VoWIFI	No	
VVLAIN	3GHZ		INO	VVVVAIN	Google Duo		
Bluetooth	2.4GHz	DT	No	WWAN	NA	No	

VO: Voice CMRS/PSTN Service Only

VD: Voice CMRS/PSTN and Data Service

DT: Digital Transport

^{*} HAC Rating was not based on concurrent voice and data modes; Non-current mode was found to represent worst case rating for both M and T rating.



4. Reference Documents

The following document listed in this section is referred for testing.

Reference	Title			
	American National Standard for Methods of Measurement of			
ANSI C63.19-2011	Compatibility between Wireless Communication Devices and	2011		
	Hearing Aids			
KDB 285076 D01	Equipment Authorization Guidance for Hearing Aid	V06r03		
KDB 203076 D01	Compatibility	v06r02		
	Guidance for performing T-Coil tests for air interfaces			
KDB 285076 D02	supporting voice over IP (e.g., LTE and WiFi) to support CMRS	v04		
	based telephone services			
KDB 285076 D03	Heading Aid Compatibility Frequently Asked Questions	v01r06		



5. Operational Conditions During Test

5.1. HAC Measurement Set-up

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core2 1.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

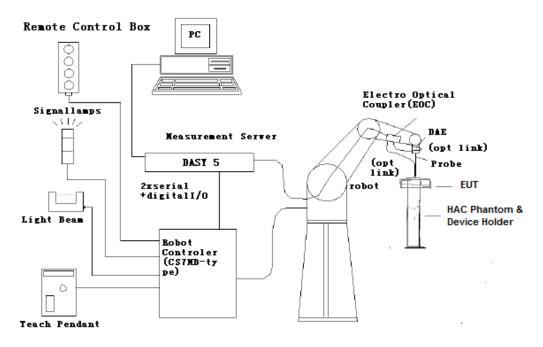


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



5.2. Probe Specification

E-Field Probe Description

Construction

Built-in shielding against static charges

One dipole parallel, two dipoles normal to probe axis

PEEK enclosure material

Calibration In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%,

k=2)

Frequency 40 MHz to > 6 GHz (can be extended to < 20 MHz)

Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity ± 0.2 dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

Dynamic Range 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB

Dimensions Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm

Application General near-field measurements up to 6 GHz

Field component measurements

Fast automatic scanning in phantoms



[ER3DV6]



5.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: $370 \times 370 \times 370 \text{ mm}$).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field <±0.5 dB.

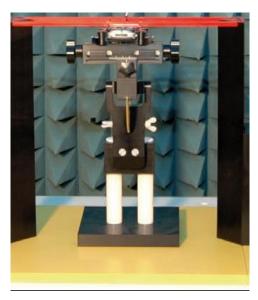


Fig. 2 HAC Phantom & Device Holder

5.4. Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: RX160XL

Repeatability: ±0.02 mm

No. of Axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller

Processor: Intel Core2 Clock Speed: 1.86 GHz

Operating System: Windows XP

Data Converter

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock



6. EUT Arrangement

6.1. WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear
- The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

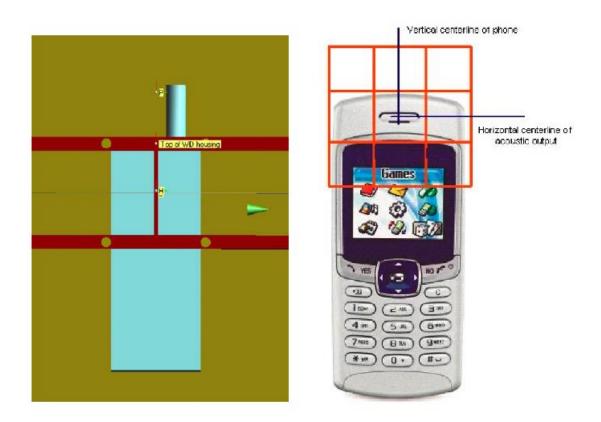


Fig. 3 WD reference and plane for RF emission measurements



7. System Validation

7.1. Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical output. Position the E-field probes so that:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) are 15 mm from the closest surface of the dipole elements.

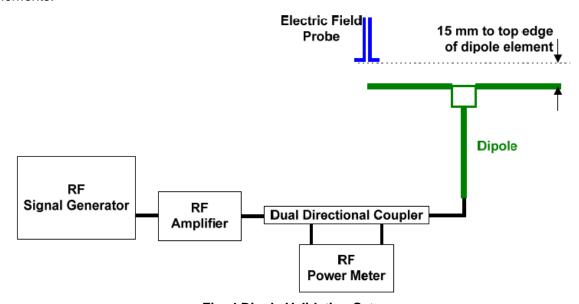


Fig. 4 Dipole Validation Setup

7.2. Validation Result

	E-Field Scan						
Mode Frequenc		Input Power	Measured ¹	Target ²	Deviation ³	Limit⁴	
Wiode	(MHz)	(mW)	Value(dBV/m)	Value(dBV/m)	(%)	(%)	
CW	835	100	44.13	41.15	7.24	±25	
CW	1880	100	39.84	38.93	2.34	±25	
CW	2600	100	39.96	38.62	3.47	±25	

Notes:

- 1. Please refer to the attachment for detailed measurement data and plot.
- 2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
- 3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.
- 4. ANSI C63.19 requires values within \pm 25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.



8. Modulation Interference Factor (MIF)

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF) which replaces the need for the Articulation Weighting Factor (AWF) during the evaluation and is applicable to any modulation scheme.

The Modulation Interference factor (MIF, in dB) is added to the measured average E-field (in dBV/m) and converts it to the RF Audio Interference level (in dBV/m). This level considers the audible amplitude modulation components in the RF E-field. CW fields without amplitude modulation are assumed to not interfere with the hearing aid electronics. Modulations without time slots and low fluctuations at low frequencies have low MIF values, TDMA modulations with narrow transmission and repetition rates of few 100 Hz have high MIF values and give similar classifications as ANSI C63-2007.

Definitions

ER3D, E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the "indirect" measurement method according to ANSI C63.19-2011 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by probe modulation response (PMR) calibration in order to not overestimate the field reading.

The evaluation method or the MIF is defined in ANSI C63.19-2011 section D.7. An RMS demodulated RF signal is fed to a spectral filter (similar to an A weighting filter) and forwarded to a temporal filter acting as a quasi-peak detector. The averaged output of these filtering is called to a 1 kHz 80% AM signal as reference. MIF measurement requires additional instrumentation and is not well suited for evaluation by the end user with reasonable uncertainty It may alternatively be determined through analysis and simulation, because it is constraint and characteristic for a communication signal. DASY52 uses well defined signals for PMR calibration. The MIF of these signals has been determined by simulation and is automatically applied.

MIF values were not tested by a probe or as specified in the standards but are based on analysis provided by SPEAG for all the air interfaces (GSM, WCDMA, CDMA, LTE). The data included in this report are for the worst case operating modes. The UIDs used are listed below:



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UID	Communication System Name	MIF (dB)
10021	GSM-FDD (TDMA, GMSK)	3.63
10025	EDGE-FDD (TDMA, 8PSK, TN 0)	3.75
10460	UMTS-FDD (WCDMA, AMR)	-25.43
10097	UMTS-FDD (HSDPA)	-20.75
10170	LTE-FDD(SC-FDMA, 1RB, 20MHz, 16-QAM)	-9.76
10176	LTE-FDD(SC-FDMA, 1RB, 10MHz, 16-QAM)	-9.76
10173	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16QAM)	-1.44
10769	5G NR (CP-OFDM, 1 RB, 15 MHz, QPSK, 15 kHz)	-12.08
10061	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02
10069	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps)	-3.15

A PMR calibrated probe is linearized for the selected waveform over the full dynamic range within the uncertainty specified in its calibration certificate. ER3D, EF3D and EU2D E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the \indirect" measurement method according to ANSI C63.19-2011 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by PMR calibration in order to not overestimate the field reading.

The MIF measurement uncertainty is estimated as follows, for modulation frequencies from slotted waveforms with fundamental frequency and at least 2 harmonics within 10 kHz:

0.2 dB for MIF -7 to +5 dB, 0.5 dB for MIF -13 to +11 dB 1 dB for MIF > -20 dB



9. Evaluation for low-power exemption

9.1. Product testing threshold

There are two methods for exempting an RF air interface technology from testing. The first method requires evaluation of the MIF for the worst-case operating mode. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is \leq 17 dBm for any of its operating modes. The second method does not require determination of the MIF. The RF emissions testing exemption shall be applied to an RF air interface technology in a device whose peak antenna input power, averaged over intervals \leq 50 μ s20, is \leq 23 dBm. An RF air interface technology that is exempted from testing by either method shall be rated as M4. The two methods are used to be exempt from testing for the RF air interface technology in this report.

9.2. Average conducted power

Antenna	Band	power (dBm)	MIF (dB)	Sum (dBm)	HAC Test
Ant.1 & Ant.2	GSM 850	33.0	3.63	36.63	Yes
Ant.1 & Ant.2	EDGE 850	26.5	3.75	30.25	Yes
Ant.0 & Ant.2	GSM 1900	30.0	3.63	33.63	Yes
Ant.0 & Ant.2	EDGE 1900	26.5	3.75	30.25	Yes
Ant.0 & Ant.2	WCDMA B2	24.0	-25.43	-1.43	No
Ant.0 & Ant.2	WCDMA B2 - HSDPA	24.0	-20.75	3.25	No
Ant.0 & Ant.2	WCDMA B4	24.0	-25.43	-1.43	No
Ant.0 & Ant.2	WCDMA B4 - HSDPA	24.0	-20.75	3.25	No
Ant.1 & Ant.2	WCDMA B5	24.0	-25.43	-1.43	No
Ant.1 & Ant.2	WCDMA B5 - HSDPA	24.0	-20.75	3.25	No
Ant.0 & Ant.2	LTE Band 2	24.0	-9.76	14.24	No
Ant.0 & Ant.2	LTE Band 4	24.0	-9.76	14.24	No
Ant.1 & Ant.2	LTE Band 5	24.0	-9.76	14.24	No
Ant.2	LTE Band 7	24.0	-9.76	14.24	No
Ant.0	LTE Band 7	23.0	-9.76	13.24	No
Ant.1 & Ant.2	LTE Band 12	24.0	-9.76	14.24	No
Ant.1 & Ant.2	LTE Band 13	24.0	-9.76	14.24	No
Ant.1 & Ant.2	LTE Band 17	24.0	-9.76	14.24	No
Ant.0 & Ant.2	LTE Band 25	24.0	-9.76	14.24	No
Ant.1 & Ant.2	LTE Band 26	24.0	-9.76	14.24	No
Ant.0 & Ant.2	LTE Band 66	24.0	-9.76	14.24	No
Ant.1 & Ant.2	LTE Band 71	24.0	-9.76	14.24	No
Ant.0 & Ant.2	LTE Band 38	23.5	-1.44	22.06	Yes
Ant.0 & Ant.2	LTE Band 41 PC3	24.0	-1.44	22.56	Yes
Ant.2	LTE Band 41 PC2	26.5	-1.44	25.06	Yes
Ant.0	LTE Band 41 PC2	25.5	-1.44	24.06	Yes
Ant.5	LTE Band 42	24.0	-1.44	22.56	Yes



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Ant.0	LTE Band 42	23.0	-1.44	21.56	Yes
Ant.5	LTE Band 43	24.0	-1.44	22.56	Yes
Ant.0	LTE Band 43	23.0	-1.44	21.56	Yes
Ant.0 & Ant.5	LTE Band 48	24.0	-1.44	22.56	Yes
Ant.0 & Ant.2	NR n2	24.0	-12.08	11.92	No
Ant.1 & Ant.2	NR n5	24.0	-12.08	11.92	No
Ant.0 & Ant.2	NR n7	24.0	-12.08	11.92	No
Ant.0 & Ant.2	NR n25	24.0	-12.08	11.92	No
Ant.0 & Ant.2	NR n38	24.0	-12.08	11.92	No
Ant.0 & Ant.2	NR n41 PC3	24.0	-12.08	11.92	No
Ant.0 & Ant.2	NR n41 PC2	27.0	-12.08	14.92	No
Ant.0 & Ant.5	NR n48	24.0	-12.08	11.92	No
Ant.0 & Ant.2	NR n66	24.0	-12.08	11.92	No
Ant.1 & Ant.2	NR n71	24.0	-12.08	11.92	No
Ant.0 & Ant.5	NR n77 PC3	24.0	-12.08	11.92	No
Ant.0 & Ant.5	NR n78 PC3	24.0	-12.08	11.92	No
Ant.0 & Ant.5	NR n78 PC2	27.0	-12.08	14.92	No
Ant.9	WLAN 2.4GHz	17.0	-2.02	14.98	No
Ant.9	WLAN 5GHz	16.0	-3.15	12.85	No

Note:

- 1. Power = Max tune-up limit
- 2. EDGE data modes are not necessary due the GSM Voice mode is the worst case.

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10. RF Test Procedures

The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplify this positioning.
- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Evaluate the MIF and add to the maximum steady-state rms field-strength reading to obtain the RF audio interference level..
- Compare this RF audio interference level with the categories and record the resulting WD category rating.



11. Measurement Results (E-Field)

Fred	luency	Measured Value	Power Drift	
Channel	MHz	(dBV/m)	(dB)	Category
L		GSM 850 - A	Ant.1	
251	848.8	36.43	0.07	M4 (see Fig A.1)
190	836.6	34.79	0.05	M4 (see Fig A.2)
128	824.2	36.37	0.04	M4 (see Fig A.3)
1		GSM 850 - A	Ant.2	
251	848.8	25.46	0.01	M4 (see Fig A.4)
190	836.6	25.88	0.05	M4 (see Fig A.5)
128	824.2	26.35	0.09	M4 (see Fig A.6)
		GSM 1900 -	Ant.0	
810	1909.8	17.49	0.02	M4 (see Fig A.7)
661	1880.0	17.35	0.04	M4 (see Fig A.8)
512	1850.2	17.41	0.06	M4 (see Fig A.9)
		GSM 1900 -	Ant.2	
810	1909.8	33.04	0.02	M3 (see Fig A.10)
661	1880.0	32.97	0.00	M3 (see Fig A.11)
512	1850.2	33.94	0.06	M3 (see Fig A.12)
		LTE Band 41 PC	3 – Ant.0	
41490	2680.0	32.77	-0.01	M3 (see Fig A.13)
41055	2636.5	32.86	-0.01	M3 (see Fig A.14)
40620	2593.0	32.84	-0.03	M3 (see Fig A.15)
40185	2549.5	32.82	-0.02	M3 (see Fig A.16)
39750	2506.0	32.50	0.01	M3 (see Fig A.17)
		LTE Band 41 PC	3 – Ant.2	
41490	2680.0	31.48	-0.05	M3 (see Fig A.18)
41055	2636.5	32.32	0.00	M3 (see Fig A.19)
40620	2593.0	32.65	0.02	M3 (see Fig A.20)
40185	2549.5	32.78	0.00	M3 (see Fig A.21)
39750	2506.0	32.47	0.05	M3 (see Fig A.22)
		LTE Band 41 PC	2 – Ant.0	
41490	2680.0	30.24	0.01	M3 (see Fig A.23)
41055	2636.5	31.11	0.01	M3 (see Fig A.24)
40620	2593.0	31.66	0.00	M3 (see Fig A.25)
40185	2549.5	31.63	-0.02	M3 (see Fig A.26)
39750	2506.0	31.20	-0.03	M3 (see Fig A.27)
		LTE Band 41 PC	2 – Ant.2	
41490	2680.0	30.24	-0.01	M3 (see Fig A.28)
41055	2636.5	31.07	-0.05	M3 (see Fig A.29)
40620	2593.0	31.51	-0.04	M3 (see Fig A.30)
40185	2549.5	31.45	-0.01	M3 (see Fig A.31)



No.B23N00001-HAC RF

39750 2506.0	31.06	-0.04	M3 (see Fig A.32)
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Note:

- 1. HAC RF for LTE Band 38 is covered by LTE Band 41 PC3 due to similar frequency range, same maximum tune-up limit and same channel bandwidth.
- 2. The LTE Band 42/43/48 test data is referenced to I22Z62357-SEM10 report.



12. ANSI C 63.19-2011 Limits

WD RF audio interference level categories in logarithmic units

Emission categories	< 960 MHz				
/	E-field emissions				
Category M1	50 to 55	dB (V/m)			
Category M2	45 to 50	dB (V/m)			
Category M3	40 to 45	dB (V/m)			
Category M4	< 40	dB (V/m)			
Emission categories	> 960	MHz			
/	E-field en	nissions			
Category M1	40 to 45	dB (V/m)			
Category M2	35 to 40	dB (V/m)			
Category M3	30 to 35	dB (V/m)			
Category M4	< 30	dB (V/m)			



13. Measurement Uncertainty

No.	Error source	Туре	Uncertainty Value a _i (%)	Prob. Dist.	Div.	ABM1	ABM2 ci	Std. Unc. ABM1	Std. Unc. ABM2
1	System Repeatability	Α	0.016	N	1	1	1	0.016	0.016
			Probe	Sensitiv	ity				
2	Reference Level	В	3.0	R	$\sqrt{3}$	1	1	3.0	3.0
3	AMCC Geometry	В	0.4	R	$\sqrt{3}$	1	1	0.2	0.2
4	AMCC Current	В	0.6	R	$\sqrt{3}$	1	1	0.4	0.4
5	Probe Positioning during Calibration	В	0.1	R	$\sqrt{3}$	1	1	0.1	0.1
6	Noise Contribution	В	0.7	R	$\sqrt{3}$	0.014 3	1	0.0	0.4
7	Frequency Slope	В	5.9	R	$\sqrt{3}$	0.1	1	0.3	3.5
			Prob	e Syster	n				
8	Repeatability / Drift	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6
9	Linearity / Dynamic Range	В	0.6	N	1	1	1	0.4	0.4
10	Acoustic Noise	В	1.0	R	$\sqrt{3}$	0.1	1	0.1	0.6
11	Probe Angle	В	2.3	R	$\sqrt{3}$	1	1	1.4	1.4
12	Spectral Processing	В	0.9	R	$\sqrt{3}$	1	1	0.5	0.5
13	Integration Time	В	0.6	N	1	1	5	0.6	3.0
14	Field Distribution	В	0.2	R	$\sqrt{3}$	1	1	0.1	0.1
		1	Tes	t Signal	ı	1	T	1	
15	Ref. Signal Spectral Response	В	0.6	R	$\sqrt{3}$	0	1	0.0	0.4
			Pos	itioning					
16	Probe Positioning	В	1.9	R	$\sqrt{3}$	1	1	1.1	1.1
17	Phantom Thickness	В	0.9	R	$\sqrt{3}$	1	1	0.5	0.5
18	DUT Positioning	В	1.9	R	$\sqrt{3}$	1	1	1.1	1.1
			External	Contribu	itions	1			
19	RF Interference	В	0.0	R	$\sqrt{3}$	1	0.3	0.0	0.0
20	Test Signal Variation	В	2.0	R	$\sqrt{3}$	1	1	1.2	1.2
Con	Combined Std. Uncertainty (ABM Field) $u_c = \sqrt{\sum_{i=1}^{20} c_i^2 u_i^2}$				4.1	6.1			
Exp	anded Std. Uncertainty	ı	$u_e = 2u_c$	N		<i>k</i> = 2		8.2	12.2



14. Main Test Instruments

Table 14-1: List of Main Instruments

No.	Name	Туре	Serial Number	Calibration Date	Valid Period
01	Signal Generator	E8257D	MY47461211	2023-01-13	One year
02	Power meter	NRP	101260	2022-12-29	One year
03	Power sensor	NRP-Z91	102211	2022-12-29	One year
04	Amplifier	VTL5400	0404	/	/
05	HAC Test Arch	N/A	1150	/	/
06	DAE	DAE4	786	2022-09-29	One year
07	E-Field Probe	ER3DV6	2424	2021-03-04	Three years
08	HAC Dipole	CD835V3	1165	2021-05-18	Three years
09	HAC Dipole	CD1880V3	1149	2021-05-18	Three years
10	HAC Dipole	CD2600V3	1020	2021-05-18	Three years
11	BTS	CMW500	152499	2022-07-15	One year
12	Software	DASY5	/	/	/



ANNEX A: RF Emission Test Plot

HAC RF E-Field GSM 850 High (Ant.1)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 848.8 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 48.71 V/m; Power Drift = 0.07 dB

Applied MIF = 3.63 dB

RF audio interference level = 36.43 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
33.58 dBV/m	34.05 dBV/m	33.64 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
36.06 dBV/m	36.43 dBV/m	35.93 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
37.8 dBV/m	38.07 dBV/m	37.32 dBV/m

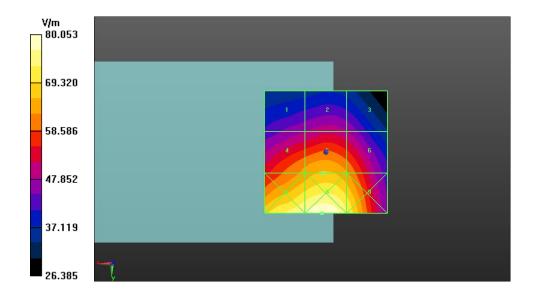


Fig A.1 HAC RF E-Field GSM850



HAC RF E-Field GSM 850 Middle (Ant.1)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 836.6 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 39.95 V/m; Power Drift = 0.05 dB

Applied MIF = 3.63 dB

RF audio interference level = 34.79 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
31.59 dBV/m	32.35 dBV/m	32.09 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
34.29 dBV/m	34.79 dBV/m	34.38 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
36.25 dBV/m	36.53 dBV/m	35.87 dBV/m

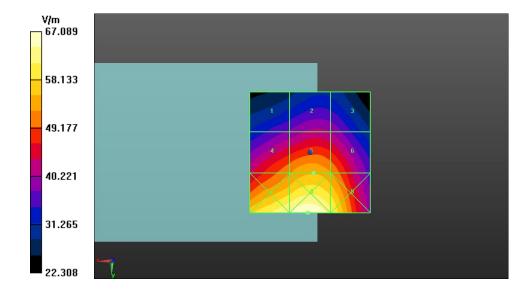


Fig A.2 HAC RF E-Field GSM850



HAC RF E-Field GSM 850 Low (Ant.1)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 824.2 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 49.49 V/m; Power Drift = 0.04 dB

Applied MIF = 3.63 dB

RF audio interference level = 36.37 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
33.49 dBV/m	34.39 dBV/m	34.16 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
35.71 dBV/m	36.37 dBV/m	36.02 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
37.33 dBV/m	37.75 dBV/m	37.17 dBV/m

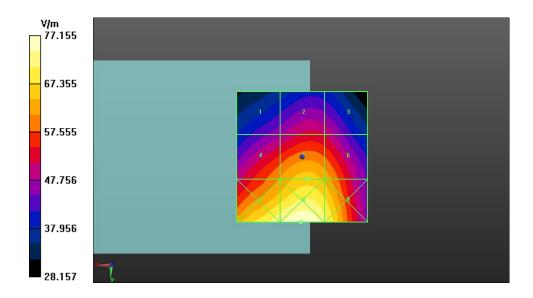


Fig A.3 HAC RF E-Field GSM850



HAC RF E-Field GSM 850 High (Ant.2)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 848.8 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 14.88 V/m; Power Drift = 0.01 dB

Applied MIF = 3.63 dB

RF audio interference level = 25.46 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
23.52 dBV/m	24.51 dBV/m	24.33 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
24.77 dBV/m	25.46 dBV/m	25.19 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.22 dBV/m	26.65 dBV/m	26.02 dBV/m

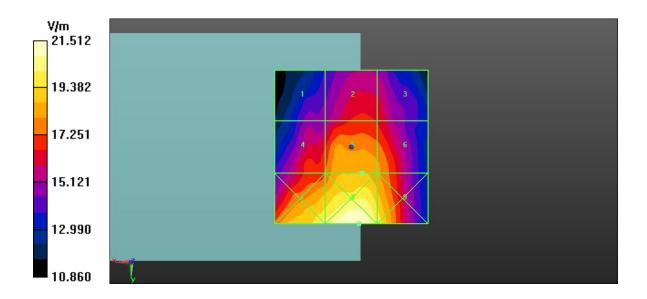


Fig A.4 HAC RF E-Field GSM850



HAC RF E-Field GSM 850 Middle (Ant.2)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 836.6 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 15.63 V/m; Power Drift = 0.05 dB

Applied MIF = 3.63 dB

RF audio interference level = 25.88 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
24.09 dBV/m	24.84 dBV/m	24.58 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
25.3 dBV/m	25.88 dBV/m	25.57 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.69 dBV/m	27.2 dBV/m	26.49 dBV/m

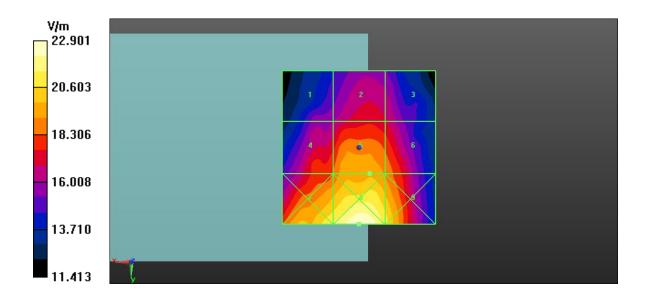


Fig A.5 HAC RF E-Field GSM850



HAC RF E-Field GSM 850 Low (Ant.2)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 824.2 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 16.48 V/m; Power Drift = 0.09 dB

Applied MIF = 3.63 dB

RF audio interference level = 26.35 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
25.72 dBV/m	25.33 dBV/m	24.93 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
26.37 dBV/m	26.13 dBV/m	25.54 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.32 dBV/m	27.22 dBV/m	26.35 dBV/m

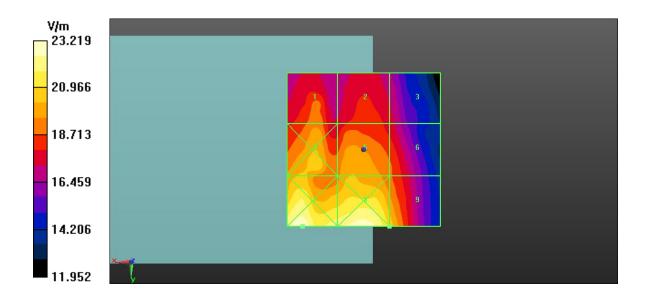


Fig A.6 HAC RF E-Field GSM850



HAC RF E-Field GSM 1900 High (Ant.0)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 1909.8 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 4.055 V/m; Power Drift = 0.02 dB

Applied MIF = 3.63 dB

RF audio interference level = 17.49 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
18.05 dBV/m	17.64 dBV/m	18.29 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
17.49 dBV/m	17.24 dBV/m	16.36 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
17.03 dBV/m	16.49 dBV/m	13.55 dBV/m

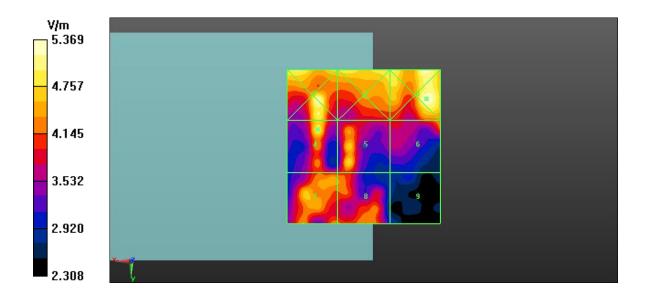


Fig A.7 HAC RF E-Field GSM1900



HAC RF E-Field GSM 1900 Middle (Ant.0)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 1880 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 4.342 V/m; Power Drift = 0.04 dB

Applied MIF = 3.63 dB

RF audio interference level = 17.35 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
17.67 dBV/m	18.29 dBV/m	18.22 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
17.35 dBV/m	17.25 dBV/m	16.52 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
17.32 dBV/m	16.84 dBV/m	14.49 dBV/m

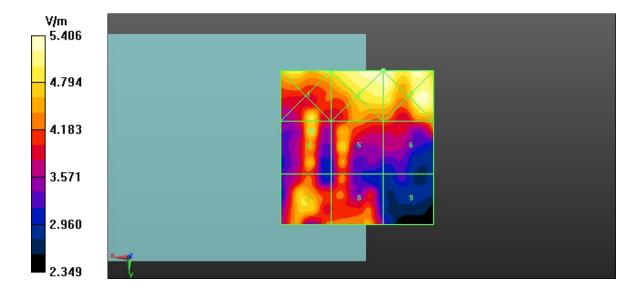


Fig A.8 HAC RF E-Field GSM1900



HAC RF E-Field GSM 1900 Low (Ant.0)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 4.286 V/m; Power Drift = 0.06 dB

Applied MIF = 3.63 dB

RF audio interference level = 17.41 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
17.37 dBV/m	18.45 dBV/m	18.51 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
17.17 dBV/m	17.16 dBV/m	16.35 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
17.41 dBV/m	16.54 dBV/m	14.16 dBV/m

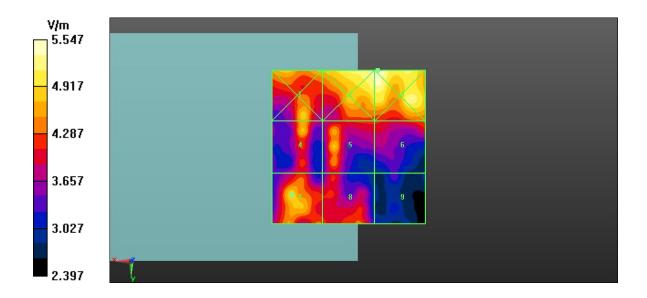


Fig A.9 HAC RF E-Field GSM1900



HAC RF E-Field GSM 1900 High (Ant.2)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 1909.8 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.70 V/m; Power Drift = 0.02 dB

Applied MIF = 3.63 dB

RF audio interference level = 33.04 dBV/m

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
36.19 dBV/m	37.5 dBV/m	37.28 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.73 dBV/m	33.04 dBV/m	33.01 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
24.65 dBV/m	27.29 dBV/m	27.29 dBV/m

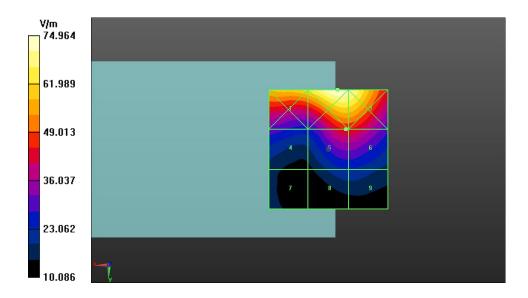


Fig A.10 HAC RF E-Field GSM1900



HAC RF E-Field GSM 1900 Middle (Ant.2)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 1880 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 23.93 V/m; Power Drift = 0.00 dB

Applied MIF = 3.63 dB

RF audio interference level = 32.97 dBV/m

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
36.64 dBV/m	37.87 dBV/m	37.58 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.73 dBV/m	32.97 dBV/m	32.95 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
25.23 dBV/m	25.93 dBV/m	25.92 dBV/m

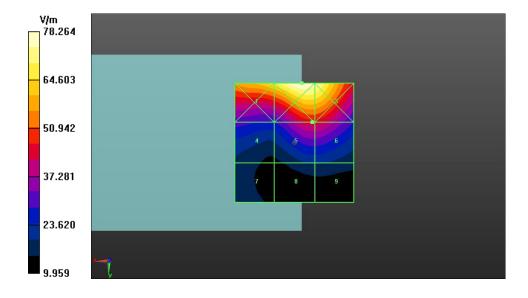


Fig A.11 HAC RF E-Field GSM1900



HAC RF E-Field GSM 1900 Low (Ant.2)

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, GSM Frequency: 1850.2 MHz Duty Cycle: 1:8.3

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.65 V/m; Power Drift = 0.06 dB

Applied MIF = 3.63 dB

RF audio interference level = 33.94 dBV/m

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
37.96 dBV/m	39.19 dBV/m	38.81 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
30.64 dBV/m	33.94 dBV/m	33.91 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.6 dBV/m	26.12 dBV/m	26.12 dBV/m

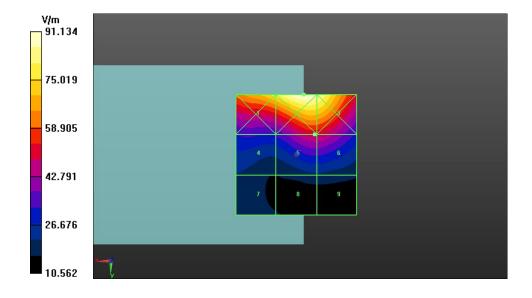


Fig A.12 HAC RF E-Field GSM1900



HAC RF E-Field LTE-Band 41 PC3 High (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2680 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 63.44 V/m; Power Drift = -0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.77 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.28 dBV/m	33.07 dBV/m	32.99 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
31.29 dBV/m	32.77 dBV/m	32.65 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
29.49 dBV/m	30.38 dBV/m	30.18 dBV/m

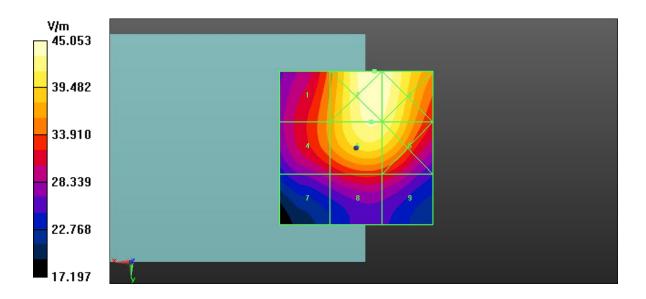


Fig A.13 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Middle-H (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2636.5 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 63.02 V/m; Power Drift = -0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.86 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.38 dBV/m	33.3 dBV/m	33.25 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
31.37 dBV/m	32.86 dBV/m	32.76 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
29.37 dBV/m	30.22 dBV/m	30.03 dBV/m

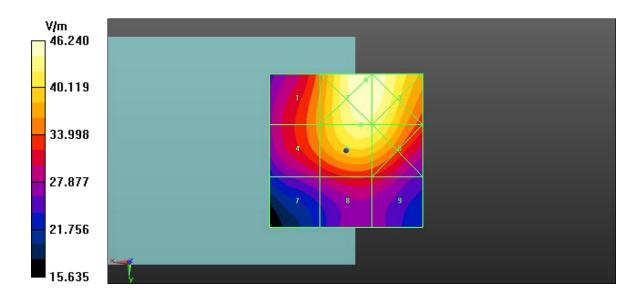


Fig A.14 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Middle-M (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2593 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 62.42 V/m; Power Drift = -0.03 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.84 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.31 dBV/m	33.45 dBV/m	33.38 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
31.27 dBV/m	32.84 dBV/m	32.72 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
29.15 dBV/m	30.25 dBV/m	30.09 dBV/m

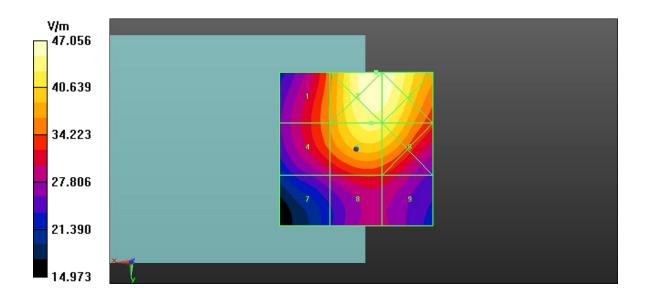


Fig A.15 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Middle-L (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2549.5 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 61.38 V/m; Power Drift = -0.02 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.82 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.9 dBV/m	33.58 dBV/m	33.54 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
30.88 dBV/m	32.82 dBV/m	32.75 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
28.88 dBV/m	30.49 dBV/m	30.43 dBV/m

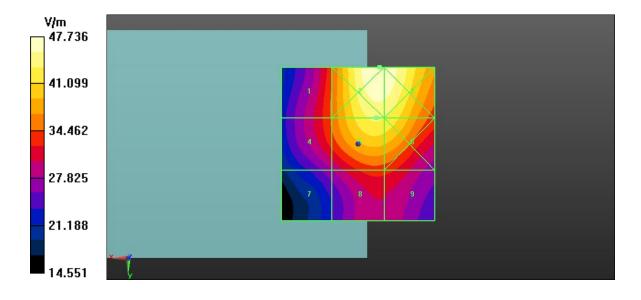


Fig A.16 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Low (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2506 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 58.99 V/m; Power Drift = 0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.50 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.04 dBV/m	33.12 dBV/m	33.11 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
30.05 dBV/m	32.5 dBV/m	32.46 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
28.41 dBV/m	30.33 dBV/m	30.27 dBV/m

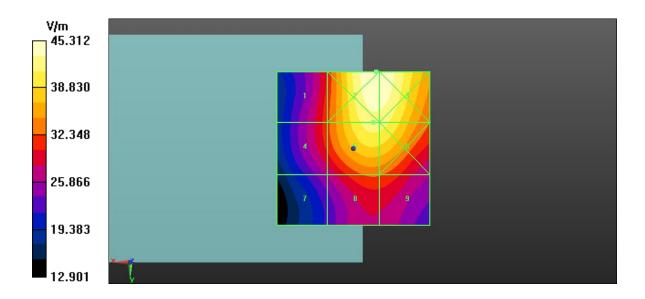


Fig A.17 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 High (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE TDD Frequency: 2680 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 55.33 V/m; Power Drift = -0.05 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.48 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.91 dBV/m	32.23 dBV/m	31.95 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.08 dBV/m	31.48 dBV/m	31.41 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.79 dBV/m	29.57 dBV/m	29.43 dBV/m

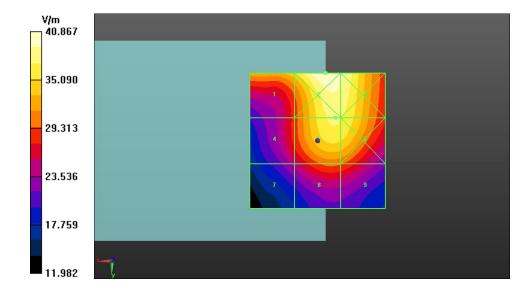


Fig A.18 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Middle-H (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2636.5 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 58.94 V/m; Power Drift = 0.00 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.32 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
32.08 dBV/m	33.29 dBV/m	32.98 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.98 dBV/m	32.32 dBV/m	32.25 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
28.06 dBV/m	29.9 dBV/m	29.8 dBV/m

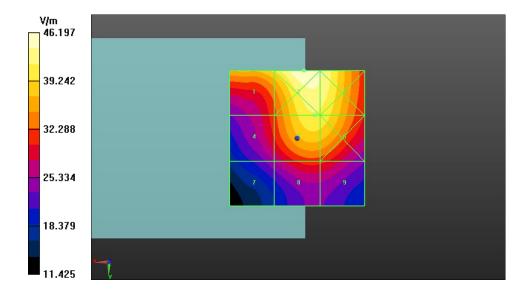


Fig A.19 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Middle-M (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2593 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 61.52 V/m; Power Drift = 0.02 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.65 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
32.46 dBV/m	33.68 dBV/m	33.41 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
30.43 dBV/m	32.65 dBV/m	32.58 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
28.41 dBV/m	30.21 dBV/m	30.05 dBV/m

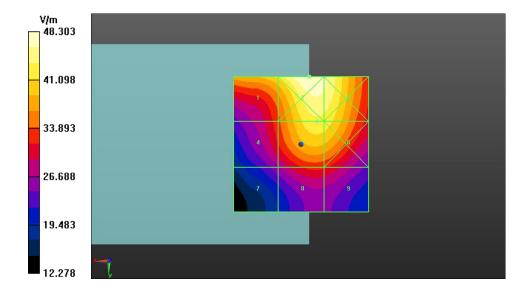


Fig A.20 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Middle-L (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2549.5 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 60.69 V/m; Power Drift = 0.00 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.78 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
32.26 dBV/m	33.74 dBV/m	33.56 dBV/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
30.1 dBV/m	32.78 dBV/m	32.74 dBV/m
Grid 7 M4	Grid 8 M3	Grid 9 M3
28.03 dBV/m	30.29 dBV/m	30.23 dBV/m

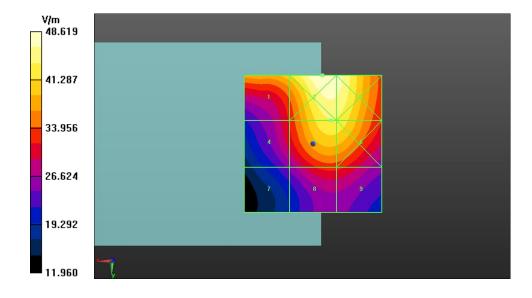


Fig A.21 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC3 Low (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2506 MHz Duty Cycle: 1:1.58

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 57.79 V/m; Power Drift = 0.05 dB

Applied MIF = -1.44 dB

RF audio interference level = 32.47 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
32.11 dBV/m	33.45 dBV/m	33.3 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.62 dBV/m	32.47 dBV/m	32.45 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.76 dBV/m	29.94 dBV/m	29.87 dBV/m

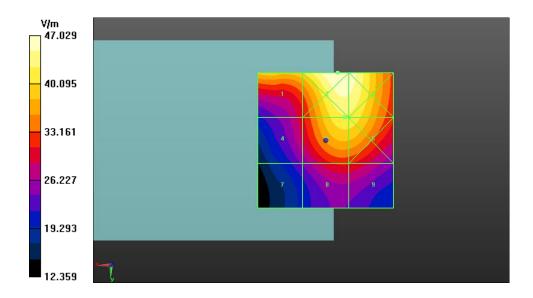


Fig A.22 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 High (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2680 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 47.93 V/m; Power Drift = 0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 30.24 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M3	Grid 3 M3
29.67 dBV/m	31.15 dBV/m	30.89 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
27.93 dBV/m	30.24 dBV/m	30.18 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.81 dBV/m	28.77 dBV/m	28.67 dBV/m

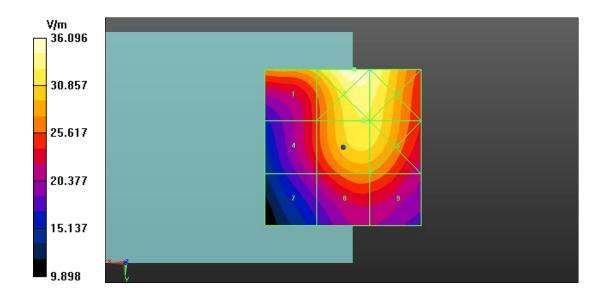


Fig A.23 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Middle-H (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2636.5 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 52.35 V/m; Power Drift = 0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.11 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.86 dBV/m	32.14 dBV/m	31.85 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28.87 dBV/m	31.11 dBV/m	31.05 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.48 dBV/m	29.55 dBV/m	29.45 dBV/m

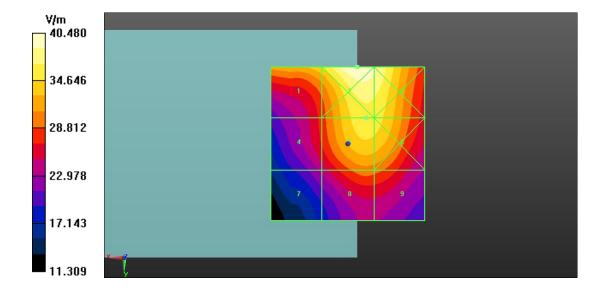


Fig A.24 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Middle-M (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2593 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 55.36 V/m; Power Drift = 0.00 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.66 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.36 dBV/m	32.64 dBV/m	32.35 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.46 dBV/m	31.66 dBV/m	31.59 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.71 dBV/m	29.79 dBV/m	29.71 dBV/m

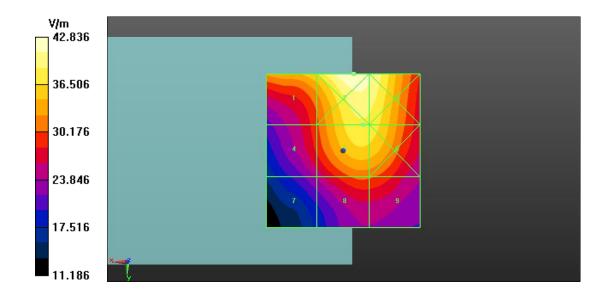


Fig A.25 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Middle-L (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2549.5 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 53.70 V/m; Power Drift = -0.02 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.63 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.15 dBV/m	32.69 dBV/m	32.45 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.01 dBV/m	31.63 dBV/m	31.59 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.16 dBV/m	29.83 dBV/m	29.82 dBV/m

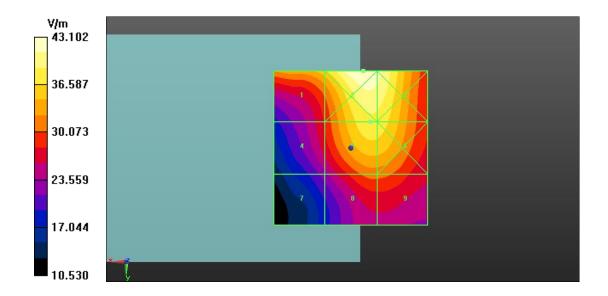


Fig A.26 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Low (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2506 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 50.31 V/m; Power Drift = -0.03 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.20 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.69 dBV/m	32.18 dBV/m	32.02 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28.11 dBV/m	31.2 dBV/m	31.19 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.53 dBV/m	29.54 dBV/m	29.54 dBV/m

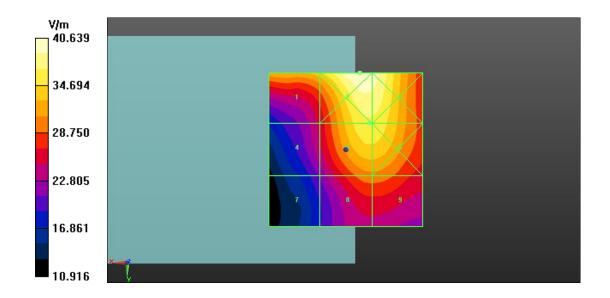


Fig A.27 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 High (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2680 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 48.02 V/m; Power Drift = -0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 30.24 dBV/m

MIF scaled E-field

Grid 1 M4	Grid 2 M3	Grid 3 M3
29.68 dBV/m	31.16 dBV/m	30.92 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
27.93 dBV/m	30.24 dBV/m	30.18 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.8 dBV/m	28.75 dBV/m	28.65 dBV/m

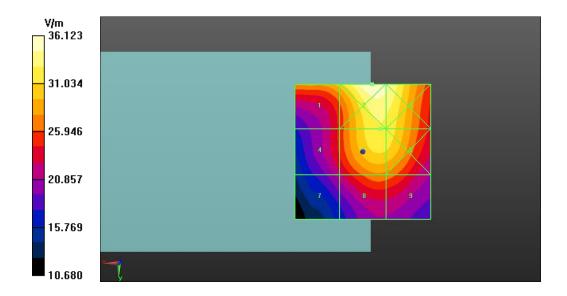


Fig A.28 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Middle-H (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2636.5 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 52.14 V/m; Power Drift = -0.05 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.07 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.87 dBV/m	32.15 dBV/m	31.86 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28.87 dBV/m	31.07 dBV/m	31 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.46 dBV/m	29.45 dBV/m	29.38 dBV/m

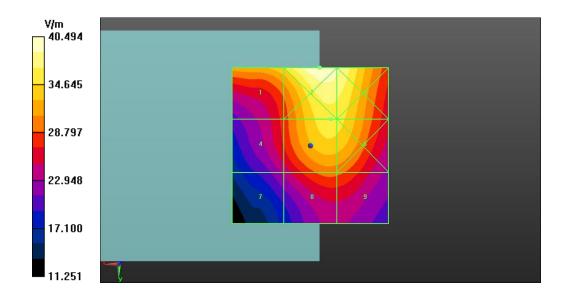


Fig A.29 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Middle-M (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2593 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 53.67 V/m; Power Drift = -0.04 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.51 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.32 dBV/m	32.7 dBV/m	32.45 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
29.37 dBV/m	31.51 dBV/m	31.41 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.52 dBV/m	29.51 dBV/m	29.44 dBV/m

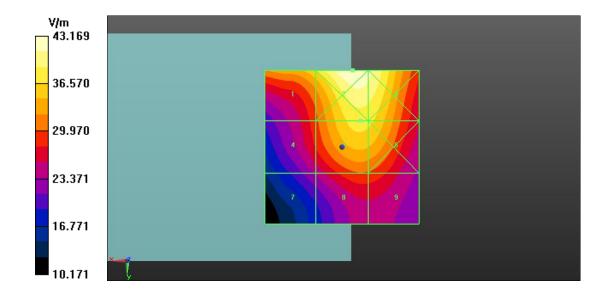


Fig A.30 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Middle-L (Ant.2)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2549.5 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 51.97 V/m; Power Drift = -0.01 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.45 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
31.05 dBV/m	32.74 dBV/m	32.54 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28.88 dBV/m	31.45 dBV/m	31.38 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.88 dBV/m	29.57 dBV/m	29.56 dBV/m

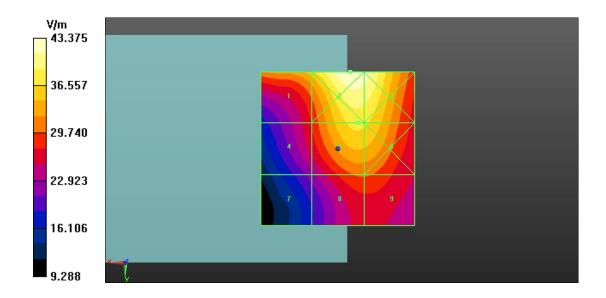


Fig A.31 HAC RF E-Field LTE-Band 41



HAC RF E-Field LTE-Band 41 PC2 Low (Ant.0)

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: UID 0, LTE_TDD Frequency: 2506 MHz Duty Cycle: 1:2.31

Probe: ER3DV6 - SN2424 ConvF (1, 1, 1);

E Scan - ER3DV6 - 2011: 15 mm from Probe Center to the Device /Hearing Aid Compatibility

Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 49.13 V/m; Power Drift = -0.04 dB

Applied MIF = -1.44 dB

RF audio interference level = 31.06 dBV/m

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
30.63 dBV/m	32.27 dBV/m	32.11 dBV/m
Grid 4 M4	Grid 5 M3	Grid 6 M3
28 dBV/m	31.06 dBV/m	31.04 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
26.35 dBV/m	29.39 dBV/m	29.39 dBV/m

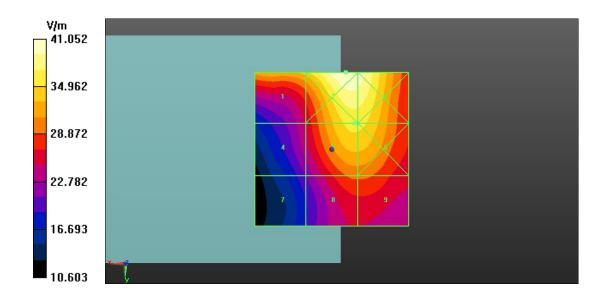


Fig A.32 HAC RF E-Field LTE-Band 41



ANNEX B: System Validation Result

835MHz

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: σ = 0 S/m, ϵ r = 1; ρ = 1000 kg/m3

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424; ConvF (1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 15mm /Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 123.5 V/m; Power Drift = 0.11 dB

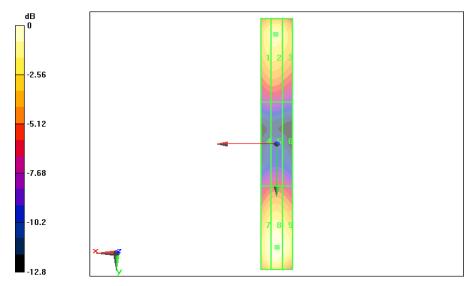
Applied MIF = 0.00 dB

RF audio interference level = 44.13 dBV/m

Emission category: M3

MIF scaled E-field

Grid 1 M3	Grid 2 M3	Grid 3 M3
43.56 dBV/m	43.97 dBV/m	43.82 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
38.99 dBV/m	39.35 dBV/m	39.24 dBV/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
43.64 dBV/m	44.13 dBV/m	43.91 dBV/m



0 dB = 44.13 dBV/m



1880MHz

Date: 2023-1-15

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424; ConvF (1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 15mm /Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

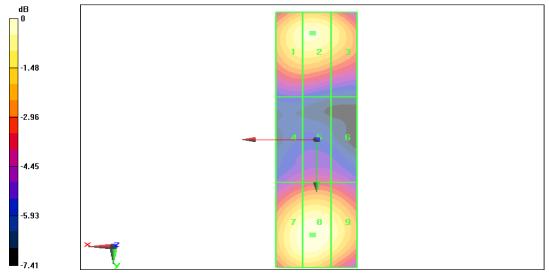
Reference Value = 112.6 V/m; Power Drift = 0.03 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.84 dBV/m

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
39.35 dBV/m	39.84 dBV/m	39.77 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
37.53 dBV/m	37.92 dBV/m	37.85 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
39.31 dBV/m	39.77 dB V/m	39.69 dBV/m



0 dB = 39.84 dBV/m



2600MHz

Date: 2023-1-16

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: ER3DV6 - SN2424; ConvF (1, 1, 1)

E Scan - measurement distance from the probe sensor center to CD2600 Dipole = 15mm /Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

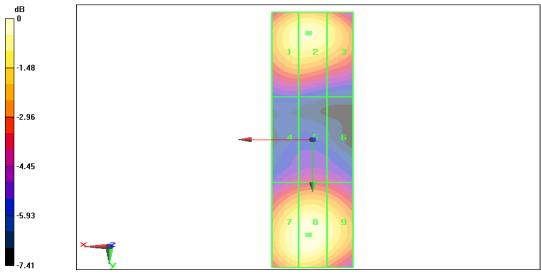
Reference Value = 75.68 V/m; Power Drift = 0.10 dB

Applied MIF = 0.00 dB

RF audio interference level = 39.96 dBV/m

MIF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
39.48 dBV/m	39.77 dBV/m	39.61 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
39.05 dBV/m	39.37 dBV/m	39.22 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
39.61 dBV/m	39.96 dB V/m	39.83 dBV/m

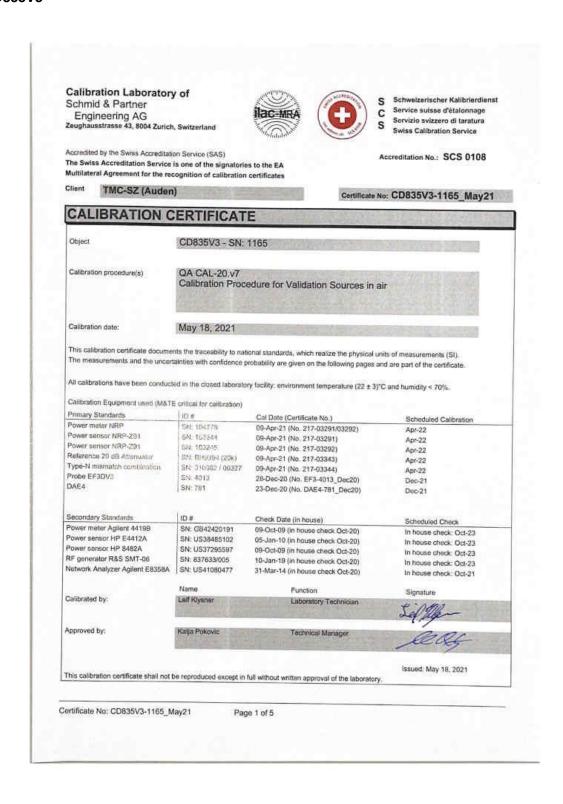


0 dB = 39.96 dBV/m



ANNEX C: Dipole Calibration Certificate

CD835V3





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





C

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

References

 ANSI-C63.19-2011
 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASYS Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a Vector Network Analyzer.
 The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallolity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD835V3-1165_May21

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Measurement Conditions

DASY system configuration, as far as not given on page 1

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	100000000000000000000000000000000000000
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	114.1 V/m = 41.15 dBV/m
Maximum measured above low end	100 mW input power	108.4 V/m = 40.70 dBV/m
Averaged maximum above arm	100 mW input power	111.3 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	17.5 dB	41.5 Ω - 8.8 Ω
835 MHz	27.8 dB	53.2 Ω + 2.7 jΩ
880 MHz	17.0 dB	60.4 Ω - 11.8 <u>j</u> Ω
900 MHz	16,7 dB	51.8 Ω - 14.9 ίΩ
945 MHz	24.9 dB	46.0 Ω + 3.7 įΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the

enhanced bendwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is

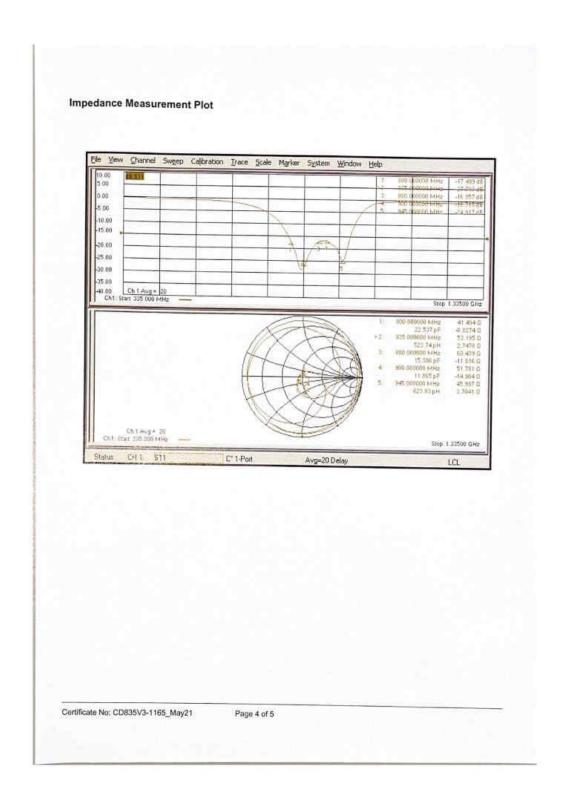
therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Certificate No: CD835V3-1165_May21

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DASY5 E-field Result

Date: 18.05.2021

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1165

Communication System: UID 0 - CW ; Frequency: 835 MHz Medium parameters used: $\alpha = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³ Phantom section: RF Section

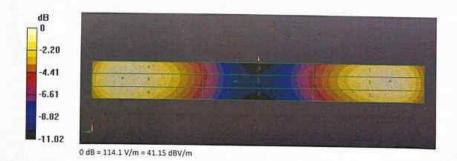
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface) Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52:10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 135.0 V/m; Power Drift = 0.01 dB
Applied MIF = 0.00 dB
RF audio interference level = 41.15 dBV/m
Emission category: M3

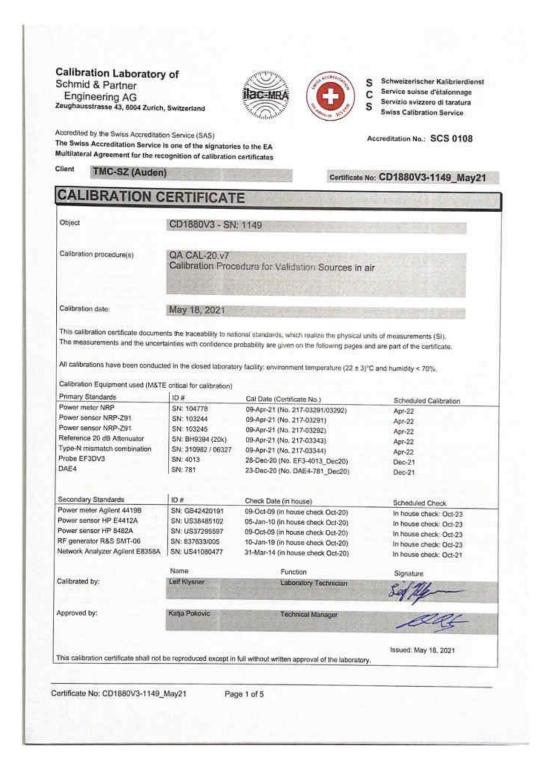
Grid 1 M3	Grid 2 M3	Grid 3 M3
40.65 dBV/m	40.7 dBV/m	40.35 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
35.83 dBV/m	35.86 dBV/m	35.57 dBV/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
41.07 dBV/m	41.15 dBV/m	40.84 dBV/m



Certificate No: CD835V3-1165_May21

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CD1880V3





Calibration Laboratory of Schmid & Partner Engineering AG Zeughauastrasse 43, 8004 Zurich, Switzerland





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C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

References

1] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipple connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a Vector Network Analyzer.
 The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD1880V3-1149_May21

Page 2 of 5

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	The same of the sa
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	88.4 V/m = 38.93 dBV/m
Maximum measured above low end	100 mW input power	86.7 V/m = 38.76 dBV/m
Averaged maximum above arm	100 mW input power	87.5 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
1730 MHz	24.1 dB	54.4 Ω + 4.8 įΩ
1880 MHz	22.6 dB	54.8 Ω + 6.2 jΩ
1900 MHz	23.1 dB	56.3 Ω + 3.9 ΙΩ
1950 MHz	30.8 dB	52.7 Ω - 1.3 iΩ
2000 MHz	21.6 dB	44.8 Ω + 5.9 ΙΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the

enhanced bandwidth.

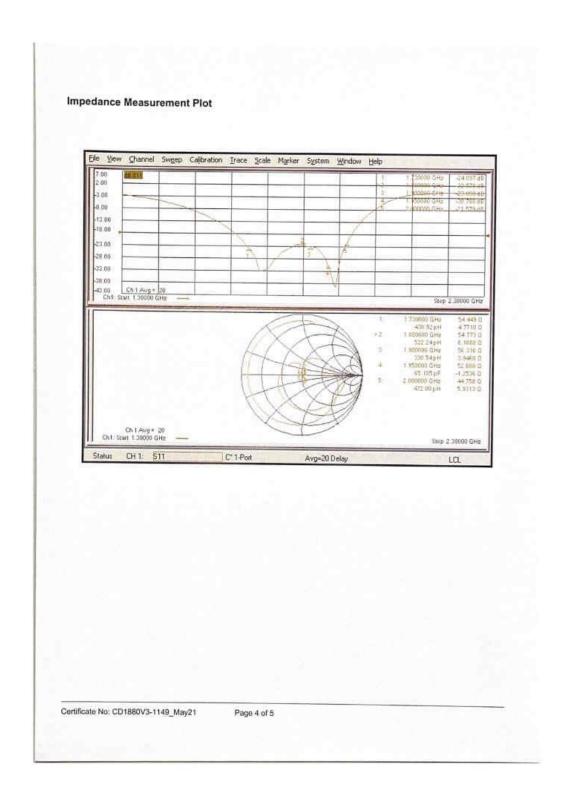
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Certificate No: CD1880V3-1149_May21

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DASY5 E-field Result

Date: 18.05.2021

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1149

Communication System: UID 0 - CW; Frequency: 1880 MHz Medium parameters used: $\sigma=0$ S/m, $\epsilon_r=1$; $\rho=0$ kg/m¹ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

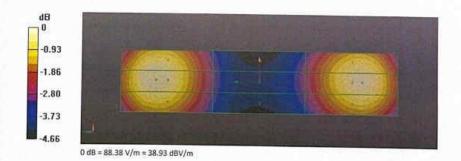
DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 1880 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 161.6 V/m; Power Drift = -0.01 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.93 dBV/m
Emission category: M2

MIF scaled E-field

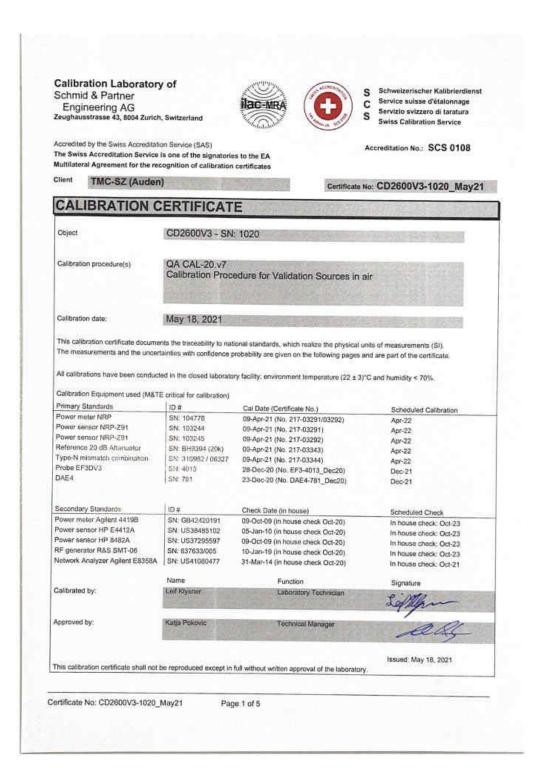
	Grid 2 M2 38.76 dBV/m	Grid 3 M2 38.5 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
36.09 dBV/m	36.12 dBV/m	35.97 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
38.83 dBV/m	38.93 dBV/m	38.63 dBV/m



Certificate No: CD1880V3-1149_May21

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CD2600V3





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

References

 ANSI-C63.19-2011
 American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenne Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASYS Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a Vector Network Analyzer.
 The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD2600V3-1020_May21

Page 2 of 5

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	AMMITANIANI
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	2600 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 2600 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	85.3 V/m = 38.62 dBV/m
Maximum measured above low end	100 mW input power	83.2 V/m = 38.40 dBV/m
Averaged maximum above arm	100 mW input power	84.3 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
2450 MHz	18.0 dB	42.7 Ω - 9.2 jΩ
2550 MHz	26.7 dB	45.9 Ω + 1.6 μΩ
2600 MHz	34.5 dB	49.3 Ω + 1.7 jΩ
2650 MHz	33.6 dB	52.1 Ω + 0.5 μΩ
2750 MHz	19.9 dB	50.7 Ω - 10.2 μΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is

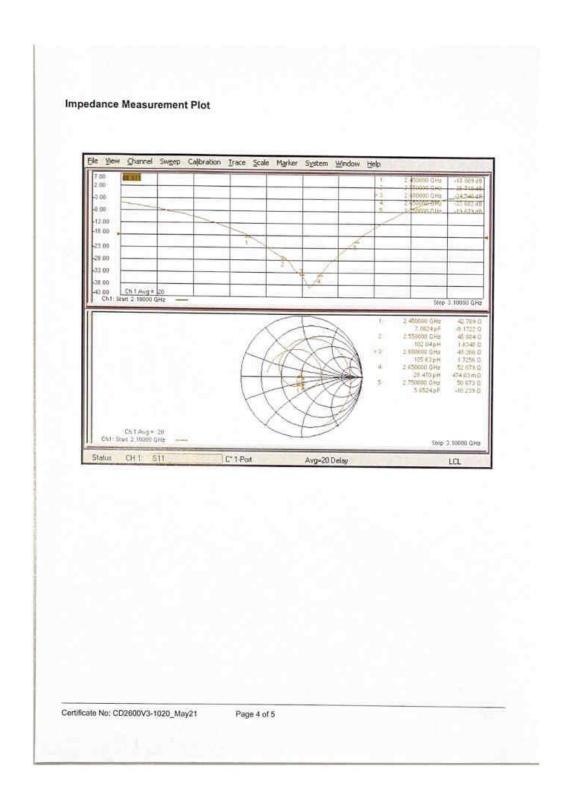
therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Certificate No: CD2600V3-1020_May21

Page 3 of 5



DASY5 E-field Result

Date: 18.05.2021

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2600 MHz; Type: CD2600V3; Serial: CD2600V3 - SN: 1020

Communication System: UID 0 - CW; Frequency; 2600 MHz Medium parameters used: σ = 0 S/m, ϵ_e = 1; ρ = 0 kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 SN4013; ConvF(1, 1, 1) @ 2600 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface)
 Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

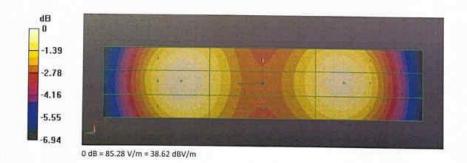
Dipole E-Field measurement @ 2600MHz/E-Scan - 2600MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 67.80 V/m; Power Drift = 0.00 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.62 dBV/m

Emission category: M2

MIF scaled E-field

Grid 1 M2 38.28 d8V/m		Grid 3 M2 38.16 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
37.79 dBV/m	37.85 dBV/m	37.68 dBV/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
38.51 dBV/m	38.62 dBV/m	38.37 dBV/m



Certificate No: CD2600V3-1020_May21

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ANNEX D: Probe Calibration Certificate

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Client

TMC-SZ (Auden)

Certificate No: ER3-2424 Mar21

CALIBRATION CERTIFICATE

Object ER3DV6- SN:2424

Calibration procedure(s) QA CAL-02.v9, QA CAL-25.v7

Calibration procedure for E-field probes optimized for close near field

evaluations in air

Calibration date: March 4, 2021

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3) °C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-291	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: CC2552 (20x)	31-Mar-20 (No. 217-03106)	Apr-21
DAE4	SN: 789	23-Dec-20 (No. DAE4-789 Dec20)	Dec-21
Reference Probe ER3DV6	SN: 2328	05-Oct-20 (No. ER3-2328_Oct20)	Oct-21
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	66-Apr-16 (in house check Jun-20)	In house check: Jun-22
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-20)	In house check: Jun-22
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-20)	In house check: Jun-22
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-20)	In house check: Jun-22
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-20)	In house check: Oct-21

Calibrated by:

Name
Function
Signature
Laboratory Technician

Approved by:

Katja Pokovic
Technical Manager
Issued: March 4, 2021

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ER3-2424_Mar21

Page 1 of 9

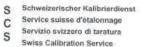


Calibration Laboratory of Schmid & Partner









Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point CF

orest factor (1/duty_cycle) of the RF signal modulation dependent linearization parameters A, B, C, D incident E-field orientation normal to probe axis Ep incident E-field orientation parallel to probe axis

Polarization o o rotation around probe axis

Polarization 9 a rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 9 = 0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system.

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, * IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz". December 2005
 b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f \leq 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z; A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup
- Sensor Offset. The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no

Certificate No: ER3-2424_Mar21

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ER3DV6 - SN:2424

March 4, 2021

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	1.53	1.55	1.83	± 10.1 %
DCP (mV) ^E	99.3	99.8	101.3	132,1337,78

Calibration results for Frequency Response (30 MHz - 3 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2)
30	77.1	76.6	-0.7%	77.4	0.4%	± 5.1%
100	77.2	78.5	1.8%	77.9	0.9%	± 5.1%
450	77.2	78.6	1.9%	77.8	0.8%	± 5.1 %
600	77.0	78.2	1.5%	77.5	0.6%	± 5.1 %
750	77.0	78.1	1.5%	77.5	0.7%	± 5.1 %
1800	143.0	141.7	-0.9%	141.1	-1.3%	± 5.1 %
2000	135.1	134.4	-0.5%	133.5	-1.2%	± 5.1 %
2200	127.7	126.2	-1.2%	127.5	-0.1%	± 5.1 %
2500	125.5	126.0	0.4%	126,8	1.1%	± 5.1 %
3000	79.4	78.2	-1.6%	81.3	2.4%	± 5.1 %

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2424_Mar21

Numerical linearization parameter: uncertainty not required.
Lincertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

ER3DV6 - SN:2424

March 4, 2021

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB√μV	С	D dB	VR mV	Max dev.	Unction (k=2)
0	:CW	X	0.0	0.0	1.0	0.00	207.1	±3.5 %	± 4.7 %
		Y	0.0	0.0	1.0		194.8		-
		Z	0.0	0.0	1.0		208.5		
10021- DAC	GSM-FDD (TDMA, GMSK)	X	13.38	91.7	25.7	9.39	127.8	±3.0 %	± 4.7 %
		Y	20.31	99.9	28.1		115.1		
		Z	25.39	99.9	28.1		145.9		
10061- CAB	IEEE 802.11b WiFi 2,4 GHz (DSSS, 11 Mbps)	×	4.95	75.3	21.8	3.60	114.8	±2.2 %	± 4.7 %
		Y	4.11	72.3	20:5		106.0		
		Z	5.66	76.6	21.8		117.0		
10077- CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	X	12.21	74.8	27.6	11.00	104.9	±2.2 %	±4.7 %
		Y	13,33	78.3	29.7		144.6		
		Z	12.02	73.8	26.5		107.7		
10172- CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz. QPSK)	X	10.38	84.9	32.0	9.21	140,1	±2.5 %	± 4.7 %
		Y	8.50	78.8	28.9		126.9		
		Z	11.14	85.0	31.1		148.0		
10173- CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	×	10.60	84.6	31.9	9.48	139.5	±2.5 %	±4.7 %
		Y	9.11	80.2	29.6		127.0		
		Z	12.00	86.6	31.9		148.3		
10295- AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	×	16,51	99.7	40.5	12.49	113.2	±3.5 %	± 4.7 %
		Y	15.91	100.0	40.9		101.3		
		Z	18.42	100.0	39.2		126.2		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ER3-2424_Mar21

Mumerical linearization parameter: uncertainty not required.

Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

ER3DV6 - SN:2424

March 4, 2021

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Sensor Frequency Model Parameters

	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	-1.78	-1.32	0.22
Frequency Corr. (HF)	0.00	0.00	0.00

Other Probe Parameters

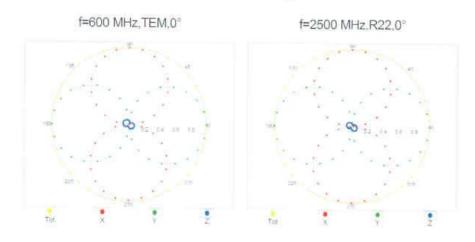
Sensor Arrangement	Rectangular
Connector Angle (*)	165.5
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2424_Mar21

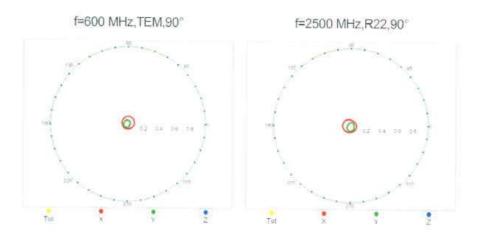
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ER3DV6 – SN:2424 March 4, 2021

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$

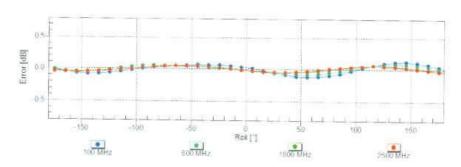


Certificate No: ER3-2424_Mar21

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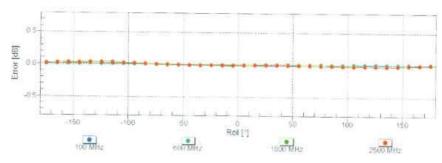
ER3DV6 - SN:2424 March 4, 2021

Receiving Pattern (\$\phi\$), \$\theta = 0^\circ\$



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (\$\phi\$), \$\text{9} = 90°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

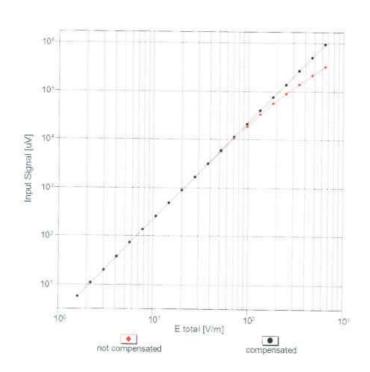
Certificate No: ER3-2424_Mar21

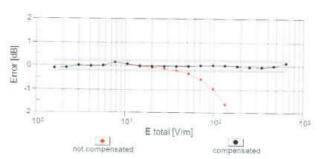
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ER3DV6 - SN:2424

March 4, 2021

Dynamic Range f(E-field) (TEM cell, f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)

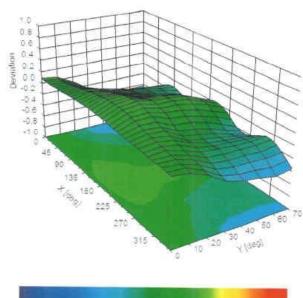
Certificate No: ER3-2424_Mar21

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March 4, 2021

ER3DV6 - SN:2424

Deviation from Isotropy in Air Error (ϕ, ϑ) , f = 900 MHz



-10 -0.8 -0.8 -0.4 -0.2 0.0 0.2 0.4 0.8 0.8 1.0

Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ER3-2424_Mar21

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ANNEX E: DAE Calibration Certificate





Client : SAICT		Certific	Certificate No: Z22-60439		
CALIBRATION (CERTIFICAT	TE .			
Object	DAE4	- SN: 786			
Calibration Procedure(s)	0.0	1-002-01 ation Procedure for the Data Ad	equisition Electronics		
Calibration date:	Septer	mber 29, 2022			
pages and are part of the	certificate, en conducted in ed (M&TE critical	the closed laboratory facility: en	probability are given on the following nvironment temperature(22±3)℃ and o.) Scheduled Calibration		
Process Calibrator 753	1971018	14-Jun-22 (CTTL, No.J22X04180)) Jun-23		
	N	Powerland	Signature		
Calibrated by:	Name Yu Zongying	Function SAR Test Engineer	Signature		
Reviewed by:	Lin Hao	SAR Test Engineer	林光		
Approved by:	Qi Dianyuan	SAR Project Leader	da		
			Issued: October 02, 2022		
크리아 경이 이 기술 때	b - II t b	oduced except in full without writte	a approval of the laborators		

Certificate No: Z22-60439

Page 1 of 3







Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2117 E-mail: emfiă-caict.ac.cn http://www.caict.ac.cn

Glossary:

DAE

data acquisition electronics

Connector angle

information used in DASY system to align probe sensor X

to the robot coordinate system.

Methods Applied and Interpretation of Parameters:

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The report provide only calibration results for DAE, it does not contain other performance test results.

Certificate No: Z22-60439

Page 2 of 3







Add: No.52 HuaYuanBei Road, Haidian District, Beijing, 100191, China

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1μV , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters; Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Υ	z
High Range	404.121 ± 0.15% (k=2)	404.267 ± 0.15% (k=2)	404.668 ± 0.15% (k=2)
Low Range	3.97160 ± 0.7% (k=2)	3.97314 ± 0.7% (k=2)	3.95725 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system 228.5	8.5° ± 1 °
---	------------

Certificate No: Z22-60439

Page 3 of 3



ANNEX F: UID Specification

Calibration Laboratory of Schmid & Partner

Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland

GSM-FDD (TDMA, GMSK)

GSM 10021-DAC

9.39 dB 3.63 dB

ETSI TS 100 909 V8.9.0 (2005-01) FCC OET KDB 941225, D03 and D04 Periodic pulsed modulation GMSK Standard Reference:

Category: Modulation:

Frequency Band:

GMSK GSM 450 (450.4 - 457.6 MHz) GSM 480 (478.8 - 486.0 MHz) GSM 710 (698.0 - 716.0 MHz) GSM 750 (747.0 - 763.0 MHz) GSM 850 (824.0 - 849.0 MHz) GSM 850 (824.0 - 849.0 MHz) P-GSM 900 (890.0 - 915.0 MHz) E-GSM 900 (880.0 - 915.0 MHz) R-GSM 900 (876.0 - 915.0 MHz) DCS 1800 (1710.0 - 1785.0 MHz) DCS 1900 (1850.0 - 1910.0 MHz) ER-GSM 900 (873.0 - 915.0 MHz) Validation band (0.0 - 6000.0 MHz)

Detailed Specification: Active Slot: TN0

Data: PN9 continuous Frame: composed out of 8 Slots

Multiframe: 26th (IDLE) Frame set blank Slottype & -timing: Normal burst for GMSK 0.2 MHz

Integration Time: 120.0 ms

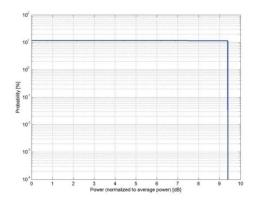
PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)"

Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

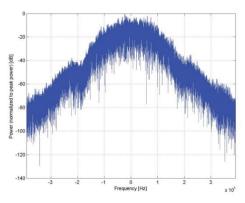


Calibration Laboratory of

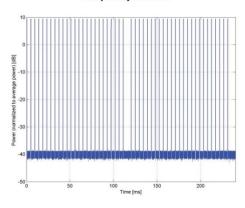
Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)



Frequency Domain



Time Domain

UID Specification Sheet

UID 10021-DAC page 2/2

16.11.2016



Calibration Laboratory of

Schmid & Partner

Name:

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

EDGE-FDD (TDMA, 8PSK, TN 0)

Group: UID: GSM 10025-DAC PAR: 1 MIF: 2 12.62 dB 3.75 dB

Standard Reference:

Category: Modulation:

Frequency Band:

ETSI TS 100 909 V8.9.0 (2005-01)
ETSI TS 100 909 V8.9.0 (2005-01)
FCC OET KDB 941225, D03 and D04
Periodic pulsed modulation
8PSK
GSM 450 (450.4 - 457.6 MHz)
GSM 470 (498.0 - 716.0 MHz)
GSM 710 (698.0 - 716.0 MHz)
GSM 750 (747.0 - 763.0 MHz)
GSM 750 (747.0 - 763.0 MHz)
P-GSM 900 (890.0 - 915.0 MHz)
P-GSM 900 (890.0 - 915.0 MHz)
R-GSM 900 (870.0 - 915.0 MHz)
DCS 1800 (1710.0 - 1785.0 MHz)
PCS 1900 (1850.0 - 1910.0 MHz)
ER-GSM 900 (873.0 - 915.0 MHz) ER-GSM 900 (873.0 - 915.0 MHz) Validation band (0.0 - 6000.0 MHz)

Detailed Specification: Active Slot: TN0

Data: PN9 continuous
Frame: composed out of 8 Slots
Multiframe: 13th (PTCCH) and 26th (IDLE) Frame set blank
Slottype & -timing: Normal burst for 8PSK
0.2 MHz
60.0 ms

Bandwidth: Integration Time:

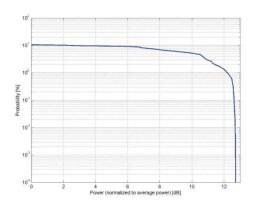
PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)"

Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

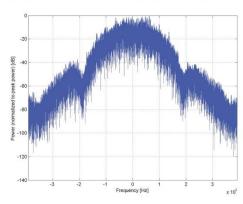


Calibration Laboratory of

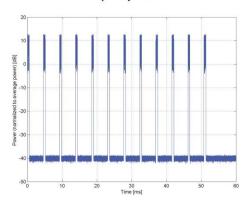
Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)



Frequency Domain



Time Domain

UID Specification Sheet

UID 10025-DAC page 2/2

16.11.2016



Calibration Laboratory of

Schmid & Partner Engineering AG

Zeughausstrasse 43, 8004 Zurich, Switzerland

Name: UMTS-FDD (WCDMA, AMR)

Group: WCDMA UID: 10460-AAA

PAR: ¹ **2.39 dB** MIF: ² **-25.43 dB**

Standard Reference: FCC OET KDB 941225 D01 SAR test for 3G devices v03

Category: Random amplitude modulation

Modulation: QPSK

Frequency Band: Band 1, UTRA/FDD (1920.0-1980.0 MHz, 20000)

Band 2, UTRA/FDD (1850.0-1910.0 MHz, 20001)
Band 3, UTRA/FDD (1710.0-1785.0 MHz, 20002)
Band 4, UTRA/FDD (1710.0-1755.0 MHz, 20003)
Band 5, UTRA/FDD (824.0-849.0 MHz, 20004)
Band 6, UTRA/FDD (830.0-840.0 MHz, 20005)
Band 7, UTRA/FDD (2500.0-2570.0 MHz, 20006)
Band 8, UTRA/FDD (880.0-915.0 MHz, 20007)
Band 9, UTRA/FDD (1749.9-1784.9 MHz, 20008)
Band 10, UTRA/FDD (1710.0-1770.0 MHz, 20009)
Band 11, UTRA/FDD (1427.9-1452.9 MHz, 20010)
Band 12, UTRA/FDD (698.0-716.0 MHz, 20011)
Band 13, UTRA/FDD (777.0-787.0 MHz, 20012)
Band 14, UTRA/FDD (788.0-798.0 MHz, 20013)
Band 19, UTRA/FDD (830.0-845.0 MHz, 20130)

Band 19, UTRA/FDD (830.0-845.0 MHz, 20130) Band 20, UTRA/FDD (832.0-862.0 MHz, 20131) Band 21, UTRA/FDD (1447.9-1462.9 MHz, 20132) Band 22, UTRA/FDD (3410.0-3490.0 MHz, 20217) Band 25, UTRA/FDD (1850.0-1915.0 MHz, 20218) Band 26, UTRA/FDD (814.0-849.0 MHz, 20219)

Detailed Specification: Dedicated Channel Type: 12.2 kbps AMR

3.4 kbps SRB

Bandwidth: 5.0 MHz Integration Time: 100.0 ms

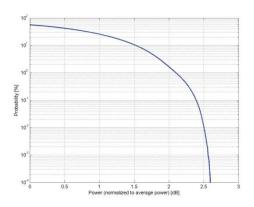
PAR (0.1%) in accordance with FCC KDB 971168, Section 6.0 "Measurement of the Peak-to-Average Power Ratio (PAPR)"

Modulation Interference Factor (MIF) value valid only in conjunction with advanced probe response linearization calibration for the same communication system (same UID and version).

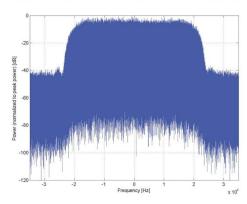


Calibration Laboratory of

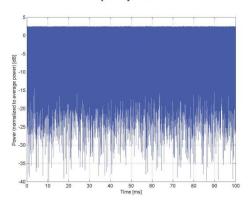
Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Complementary Cumulative Distribution Function (CCDF)



Frequency Domain



Time Domain

UID Specification Sheet

UID 10460-AAA page 2/2

14.10.2015